N-Channel 40 V (D-S) MOSFET

PRODUCT SUMMARY						
V _{DS} (V)	R _{DS(on)} (Ω)(Typ.)	I _D (A) ^{a, e}	Q _g (Typ.)			
40	0.0022 at V _{GS} = 10 V	100	70 nC			
40	0.0038 at V _{GS} = 4.5 V	75	70110			

FEATURES

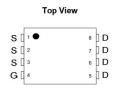
- DT-Trench Power MOSFET
- 100 % R_g and UIS Tested
- AEC-Q101 Qualified for **Automotive Applications**

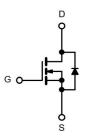


APPLICATIONS

- · Notebook PC Core
- VRM/POL







N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)					
Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	40	V	
Gate-Source Voltage		V _{GS}	± 20		
	T _C = 25 °C		100 ^{a, e}		
Continuous Drain Current (T _{.I} = 175 °C)	T _C = 70 °C	l-	70 ^e]	
Continuous Diam Current (1) = 173 C)	T _A = 25 °C	. I _D	24 ^{b, c}	A	
	T _A = 70 °C		19.8 ^{b, c}	1 ^	
Pulsed Drain Current		I _{DM}	360	7	
ralanche Current Pulse L = 0.1 mH		I _{AS}	31	1	
Single Pulse Avalanche Energy	L = 0.1 IIIA	E _{AS}	330	mJ	
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	90 ^{a, e}	А	
Continuous Source-Drain Diode Current	T _A = 25 °C	'S	3.36 ^{b, c}		
	T _C = 25 °C		250 ^a		
Maximum Power Dissipation	T _C = 70 °C	P _D	195	w	
Maximum Fower Dissipation	T _A = 25 °C] FD	3.95 ^{b, c}] vv	
	T _A = 70 °C		2.87 ^{b, c}	1	
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 175	°C	

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA} 31 40		°C/W		
Maximum Junction-to-Case	Steady State	R _{thJC}	0.5	0.6	O/VV	

Notes:

- a. Based on T_C = 25 °C. b. Surface mounted on 1" x 1" FR4 board.
- c. t = 10 s.
 d. Maximum under steady state conditions is 90 °C/W.
 e. Calculated based on maximum junction temperature.



Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$	40			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	J I _D = 250 μA		35		mV/°C	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	10 - 200 μΑ		-5.5		IIIV/ C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1.2		2.5	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA	
Zoro Cata Valtaga Brain Current	I _{DSS}	V _{DS} = 40 V, V _{GS} = 0 V	1		1		
Zero Gate Voltage Drain Current		V _{DS} = 40 V, V _{GS} = 0 V, T _J = 55 °C			10	10 µA	
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	100			Α	
	ь	$V_{GS} = 10 \text{ V}, I_D = 32 \text{ A}$		0.0022	0.0032	Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_D = 29 \text{ A}$		0.0038	0.0045		
Forward Transconductance ^a	9 _{fs}	$V_{DS} = 15 \text{ V}, I_{D} = 32 \text{ A}$		110		S	
Dynamic ^b							
Input Capacitance	C _{iss}			1015		pF	
Output Capacitance	C _{oss}	V_{DS} = 12.5 V, V_{GS} = 0 V, f = 1 MHz		875			
Reverse Transfer Capacitance	C _{rss}			571			
Total Gate Charge	Qg	V_{DS} = 15 V, V_{GS} = 10 V, I_{D} = 32 A		70		nC	
				55			
Gate-Source Charge	Q _{gs}	V_{DS} = 15 V, V_{GS} = 4.5 V, I_{D} = 29 A		30			
Gate-Drain Charge	Q _{gd}			22			
Gate Resistance	R_g	f = 1 MHz		1.4	2.1	Ω	
Turn-On Delay Time	t _{d(on)}			18	27		
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.555 Ω		11	17	1	
Turn-Off Delay Time	t _{d(off)}	$I_D\cong 27$ A, V_{GEN} = 10 V, R_g = 1 Ω		70	105		
Fall Time	t _f			10	15		
Turn-On Delay Time	t _{d(on)}			55	83	ns	
Rise Time	t _r	V_{DD} = 15 V, R_L = 0.625 Ω		180	270		
Turn-Off Delay Time	t _{d(off)}	$I_D\cong 24$ A, V_{GEN} = 4.5 V, R_g = 1 Ω		55	83		
Fall Time	t _f			12	18		
Drain-Source Body Diode Characteristic	S						
Continuous Source-Drain Diode Current	Is	T _C = 25 °C			100	Α	
Pulse Diode Forward Current ^a	I _{SM}				360	A	
Body Diode Voltage	V _{SD}	I _S = 22 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}			52	78	ns	
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 20 A, di/dt = 100 A/μs, T _J = 25 °C		70.2	105	nC	
Reverse Recovery Fall Time	t _a	1- 20 Λ, di/dt - 100 Λ/μs, 1J - 25 C		27		ns	
Reverse Recovery Rise Time	t _b			25			

Notes:

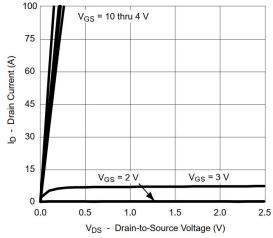
Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

a. Pulse test; pulse width \leq 300 µs, duty cycle \leq 2 %.

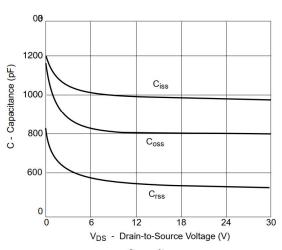
b. Guaranteed by design, not subject to production testing.



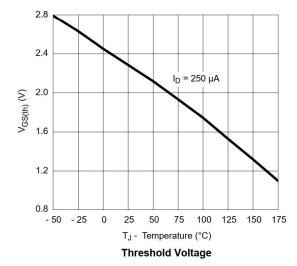
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

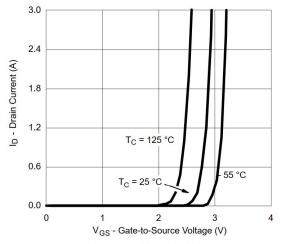


Output Characteristics

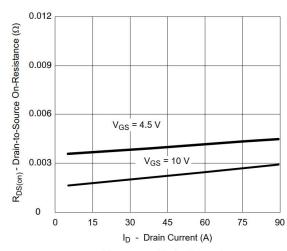


Capacitance

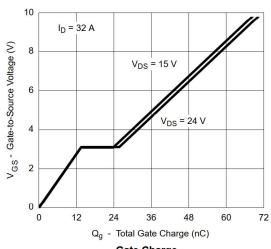




Transfer Characteristics

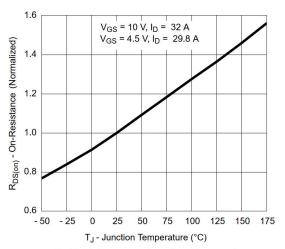


R_{DS(on)} vs. Drain Current

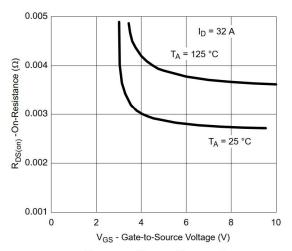


Gate Charge

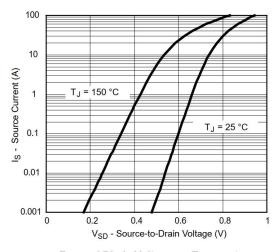
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



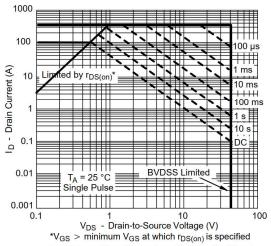
On-Resistance vs. Junction Temperature



 $R_{DS(on)} \ vs. \ V_{GS} \ vs. \ Temperature$

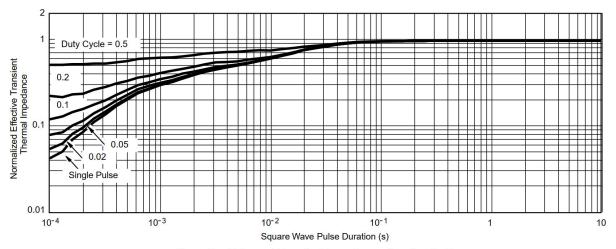


Forward Diode Voltage vs. Temperature



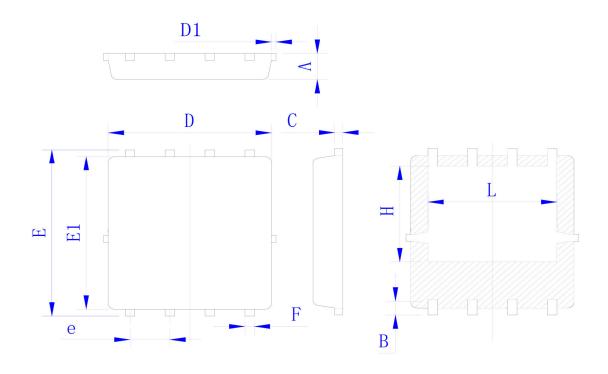
Safe Operating Area, Junction-to-Ambient

TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case

DFN5X6_8L PACKAGE OUTLINE



Symbol	Min	Тур	Max
A	0.90	0.95	1.00
В	0.48	0.58	0.68
C	0.20	0.254	0.30
D	5.00	5.20	5.40
D1			0.15
Е	5.90	6.05	6.20
E1	5.40	5.55	5.70
e	1.22	1.27	1.32
F	0.25	0.30	0.35
Н	3.27	3.47	3.67
L	3.80	4.00	4.20





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